

# SPICE Device Model Si5904DC

## **Vishay Siliconix**

## **Dual N-Channel 2.5-V (G-S) MOSFET**

#### **CHARACTERISTICS**

- N-Channel Vertical DMOS
- Macro Model (Subcircuit Model)
- Level 3 MOS

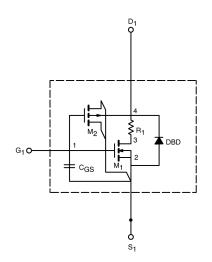
- · Apply for both Linear and Switching Application
- Accurate over the -55 to 125°C Temperature Range
- Model the Gate Charge, Transient, and Diode Reverse Recovery Characteristics

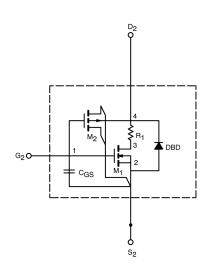
#### **DESCRIPTION**

The attached spice model describes the typical electrical characteristics of the n-channel vertical DMOS. The subcircuit model schematic is extracted and optimized over the -55 to  $125^{\circ}$ C temperature ranges under the pulsed 0-to-5V gate drive. The saturated output impedance is best fit at the gate bias near the threshold voltage.

A novel gate-to-drain feedback capacitance network is used to model the gate charge characteristics while avoiding convergence difficulties of the switched  $C_{\rm gd}$  model. All model parameter values are optimized to provide a best fit to the measured electrical data and are not intended as an exact physical interpretation of the device.

#### SUBCIRCUIT MODEL SCHEMATIC





This document is intended as a SPICE modeling guideline and does not constitute a commercial product data sheet. Designers should refer to the appropriate data sheet of the same number for guaranteed specification limits.

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SPECIFICATIONS (T <sub>J</sub> = 25°C UNLESS OTHERWISE NOTED)				
Parameter	Symbol	Test Conditions	Typical	Unit
Static				
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.02	V
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \ge 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	32	Α
		$V_{GS}$ = 4.5 V, $I_D$ = 3.1 A	0.065	
		V <sub>GS</sub> = 2.5V, I <sub>D</sub> = 2.3 A	0.011	
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 10 \text{ V}, I_D = 3.1 \text{ A}$	7	S
Diode Forward Voltage <sup>a</sup>	V <sub>SD</sub>	$I_{S} = 0.9 \text{ A}, V_{GS} = 0 \text{ V}$	0.8	٧
Dynamic <sup>b</sup>				
Total Gate Charge	Qg	$V_{DS}$ = 10 V, $V_{GS}$ = 4.5 V, $I_{D}$ = 3.1 A	3.2	nC
Gate-Source Charge	$Q_{gs}$		0.6	
Gate-Drain Charge	$Q_{gd}$		1.3	
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD} = 10 \text{ V}, \text{ R}_L = 10 \Omega$ $I_D \cong 1 \text{ A}, \text{ V}_{GEN} = 4.5 \text{ V}, \text{ R}_G = 6 \Omega$ $I_F = 0.9 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$	11	ns
Rise Time	t <sub>r</sub>		14	
Turn-Off Delay Time	t <sub>d(off)</sub>		16	
Fall Time	t <sub>f</sub>		20	
Source-Drain Reverse Recovery Time	t <sub>rr</sub>		40	

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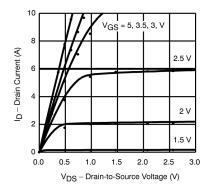
a. Pulse test; pulse width ≤ 300 µs, duty cycle ≤ 2%.
b. Guaranteed by design, not subject to production testing.

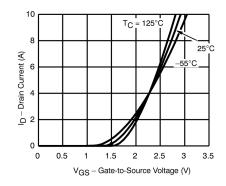


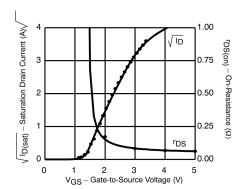


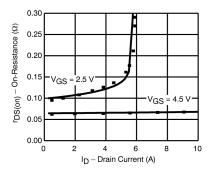
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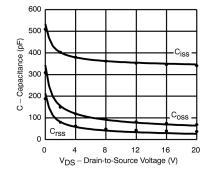
### COMPARISON OF MODEL WITH MEASURED DATA (TJ=25°C UNLESS OTHERWISE NOTED)

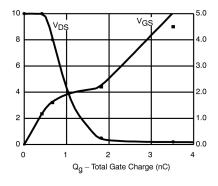












Note: Dots and squares represent measured data.

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